January 2001



# Si4466DY

# Single N-Channel 2.5V Specified PowerTrench® MOSFET

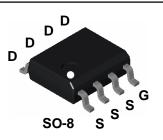
### **General Description**

This N-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

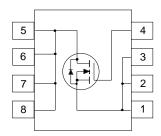
## Applications

- DC/DC converter
- Load switch
- Battery protection



#### Features

- 15 A, 20 V.  $R_{DS(on)} = 0.0075 \ \Omega \ @ V_{GS} = 4.5 \ V$  $R_{DS(on)} = 0.010 \ \Omega \ @ V_{GS} = 2.5 \ V.$
- Low gate charge (47nC typical).
- Fast switching speed.
- High performance trench technology for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability.



# Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	V
b	Drain Current - Continuous	(Note 1a)	15	А
	- Pulsed		50	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

# **Thermal Characteristics**

R <sub>θ</sub> JA	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta^{JC}}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	∘C/W

# Package Outlines and Ordering Information

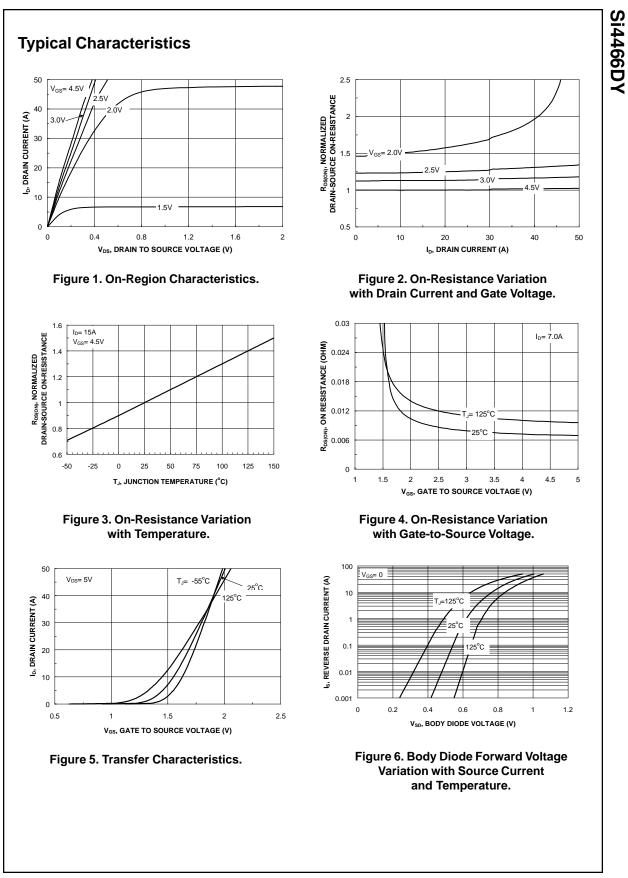
Device Marking	Device	Reel Size	Tape Width	Quantity
4466	Si4466DY	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Char	acteristics	ļ				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	20			V
<u>ΔBV<sub>DSS</sub></u> ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A$ , Referenced to $25^{\circ}C$		29		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 12 V, V_{DS} = 0 V$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -12 V, V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.4	0.9	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250\mu A$ , Referenced to $25^{\circ}C$		-4		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 V, I_D = 15 A$ $V_{GS} = 4.5 V, I_D = 15 A,$ $T_{J}=125^{\circ}C$ $V_{GS} = 2.5 V, I_D = 12 A$		0.006 0.009 0.008	0.0075 0.0130 0.0100	Ω
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5.0 \text{ V}$	25			Α
<b>g</b> fs	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		70		S
Dynamic	Characteristics					
Ciss	Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		4700		pF
Coss	Output Capacitance	f = 1.0 MHz		850		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			310		pF
Switchin	g Characteristics (Note 2)	•				<b>.</b>
t <sub>d(on)</sub>	Turn-On Delay Time	$\label{eq:VDD} \begin{split} V_{DD} &= 10 \text{ V}, \text{ I}_D = 1 \text{ A}, \\ V_{GS} &= 4.5 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega \end{split}$		20	32	ns
tr	Turn-On Rise Time			27	44	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			95	133	ns
t <sub>f</sub>	Turn-Off Fall Time			35	56	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 15 \text{ A},$		47	66	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V,$		7		nC
Q <sub>gd</sub>	Gate-Drain Charge			10.5		nC
Drain-Sc	ource Diode Characteristics an	d Maximum Ratings				
ls	Maximum Continuous Drain-Sou				2.1	Α
	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)		0.65	1.2	V
V <sub>SD</sub> Notes: 1. R <sub>θJA</sub> is the		$V_{GS} = 0 \text{ V}, \text{ I}_S = 2.1 \text{ A}$ (Note 2) sistance where the case thermal reference is ned by the user's board design.	a defined a	as the sold	1.2	V surface o

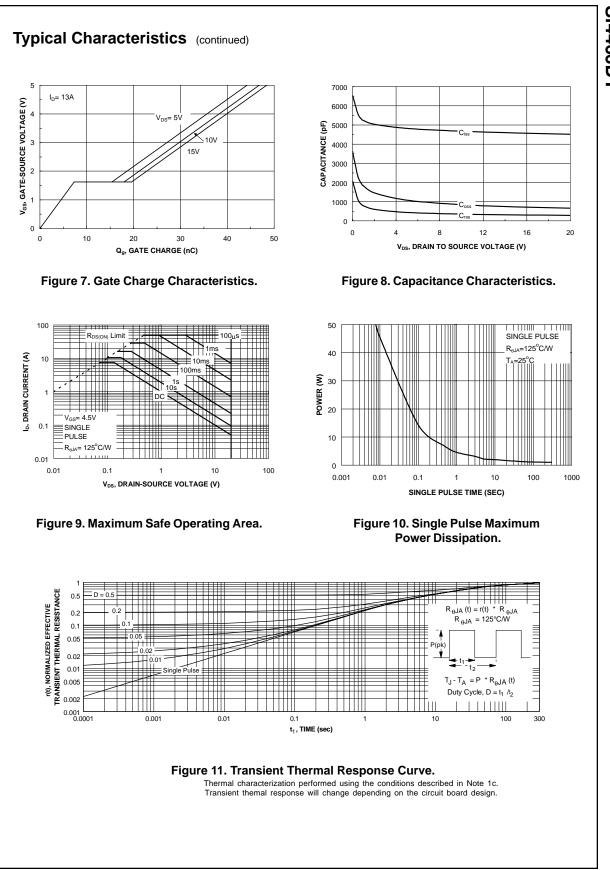
Scale 1 : 1 on letter size paper

**2.** Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2.0%

Si4466DY



Si4466DY Rev. A



# Si4466DY

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